

PC924X

- ※ Lead forming type (I type) and taping reel type (P type) are also available. (PC924XI/PC924XP)
- ※※ TÜV (VDE0884) approved type is also available as an option.

■ Features

- Built-in direct drive circuit for IGBT drive (I_{O1P} , I_{O2P} :0.4A)
- High speed response (t_{PLH} , t_{PHL} :MAX. 2.0 μ s)
- Wide operating supply voltage range
(V_{CC} :15 to 30V at T_a :-10 to 60°C)
- High noise resistance type
 CM_{IH} :MIN.-1.5kV/ μ s
 CM_{IL} :MIN.1.5kV/ μ s
- High isolation voltage (V_{iso} (rms):5.0kV)

■ Applications

- IGBT drive for inverter control

■ Absolute Maximum Ratings

(T_a = T_{opr} unless otherwise specified)

	Parameter	Symbol	Rating	Unit
Input	Forward current	I_F	25	mA
	*1 Reverse voltage	V_R	6	V
	Supply voltage	V_{CC}	35	V
Output	O_1 output current	I_{O1}	0.1	A
	*2 O_1 peak output current	I_{O1P}	0.4	A
	O_2 output current	I_{O2}	0.1	A
	*2 O_2 peak output current	I_{O2P}	0.4	A
	O_1 output voltage	V_{O1}	35	V
	Power dissipation	P_O	500	mW
	Total power dissipation	P_{tot}	550	mW
*3 Isolation voltage	V_{iso} (rms)	5.0	kV	
Operating temperature	T_{opr}	-25 to +80	°C	
Storage temperature	T_{stg}	-55 to +125	°C	
*4 Soldering temperature	T_{sol}	260	°C	

*1 T_a =25°C

*2 Pulse width \leq 0.15 μ s, Duty ratio:0.01

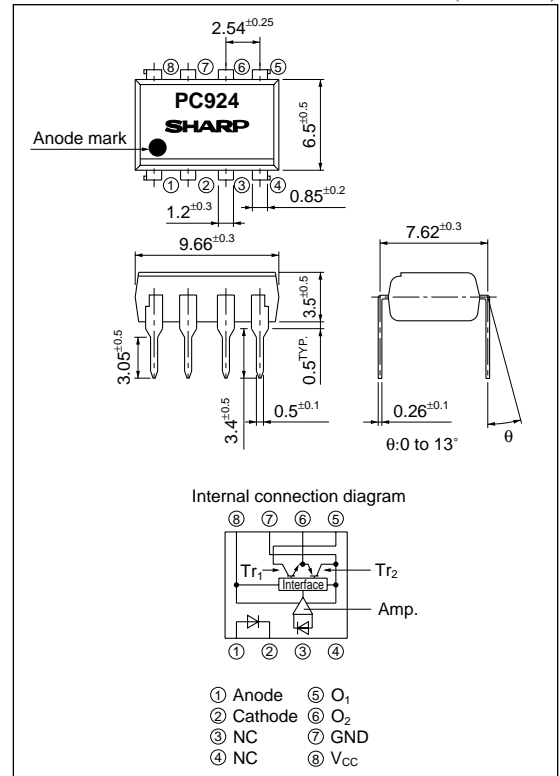
*3 40 to 60%RH, AC for 1minute, T_a =25°C

*4 For 10s

*OPIC Photocoupler for IGBT Drive of Inverter

■ Outline Dimensions

(Unit : mm)



* "OPIC" (Optical IC) is a trademark of the SHARP Corporation.
 An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

■ Electro-optical Characteristics

(T_a=T_{opr} unless otherwise specified)

Parameter		Symbol	*5 Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V _{F1}	T _a =25°C, I _F =20mA	–	1.2	1.4	V
		V _{F2}	T _a =25°C, I _F =0.2mA	0.6	0.9	–	V
	Reverse current	I _R	T _a =25°C, V _R =4V	–	–	10	μA
	Terminal capacitance	C _t	T _a =25°C, V=0, f=1kHz	–	30	250	pF
Output	Operating supply voltage	V _{CC}	T _a =–10 to 60°C	15	–	30	V
			–	15	–	24	V
	*6 O ₁ low level output voltage	V _{O1L}	V _{CC1} =12V, V _{CC2} =–12V I _{O1} =0.1A, I _F =10mA	–	0.2	0.4	V
	*7 O ₂ high level output voltage	V _{O2H}	V _{CC} =V _{O1} =24V, I _{O2} =–0.1A, I _F =10mA	18	21	–	V
	*8 O ₂ low level output voltage	V _{O2L}	V _{CC} =24V, I _{O2} =0.1A, I _F =0	–	1.2	2.0	V
	*9 O ₁ leak current	I _{O1L}	T _a =25°C, V _{CC} =V _{O1} =35V, I _F =0	–	–	500	μA
	*10 O ₂ leak current	I _{O2L}	T _a =25°C, V _{CC} =V _{O2} =35V, I _F =10mA	–	–	500	μA
	*11 High level supply current	I _{CCH}	T _a =25°C, V _{CC} =24V, I _F =10mA	–	6	10	mA
			V _{CC} =24V, I _F =10mA	–	–	14	mA
	*11 Low level supply current	I _{CCL}	T _a =25°C, V _{CC} =24V, I _F =0	–	8	13	mA
			V _{CC} =24V, I _F =0	–	–	17	mA
Transfer characteristics	*12 "Low→High" threshold input current	I _{FLH}	T _a =25°C, V _{CC} =24V	1.0	4.0	7.0	mA
			V _{CC} =24V	0.6	–	10.0	mA
	Isolation resistance	R _{ISO}	T _a =25°C, DC=500V, 40 to 60%RH	5×10 ¹⁰	10 ¹¹	–	Ω
	*13 "Low→High" propagation delay time	t _{PLH}	T _a =25°C, V _{CC} =24V, I _F =10mA R _C =47Ω, C _G =3 000pF	–	1.0	2.0	μs
				–	1.0	2.0	μs
				–	0.2	0.5	μs
				–	0.2	0.5	μs
*14 Instantaneous common mode rejection voltage "Output:High level"	CM _H	T _a =25°C, V _{CM} =600V(peak) I _F =10mA, V _{CC} =24V, ΔV _{O2H} =2.0V	–1.5	–	–	kV/μs	
			1.5	–	–	kV/μs	
*14 Instantaneous common mode rejection voltage "Output:Low level"	CM _L	T _a =25°C, V _{CM} =600V (peak) I _F =0, V _{CC} =24V, ΔV _{O2L} =2.0V	–	–	–	kV/μs	

*5 When measuring output and transfer characteristics, connect a by-pass capacitor (0.01μF or more) between V_{CC} and GND near the device

*6 Refer to Fig.1

*7 Refer to Fig.2

*8 Refer to Fig.3

*9 Refer to Fig.4

*10 Refer to Fig.5

*11 Refer to Fig.6

*12 I_{FLH} represents forward current when output goes from "Low" to "High", Refer to Fig.7

*13 Refer to Fig.8

*14 Refer to Fig.9

■ Truth Table

Input	O ₂ Output	Tr.1	Tr.2
ON	High level	ON	OFF
OFF	Low level	OFF	ON

■ Test Circuit

Fig.1

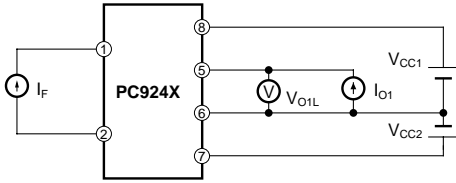


Fig.2

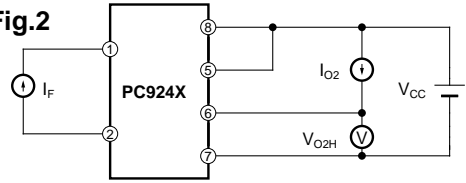


Fig.3

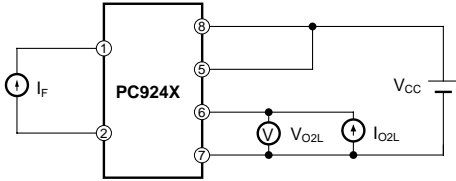


Fig.4

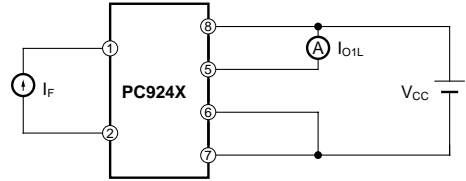


Fig.5

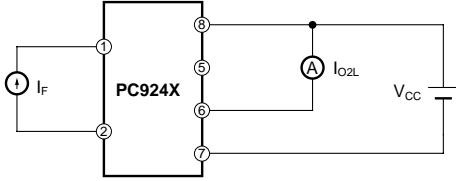


Fig.6

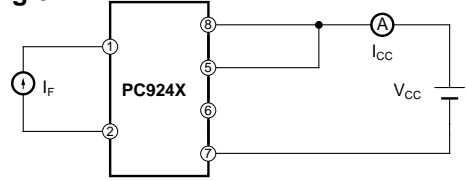


Fig.7

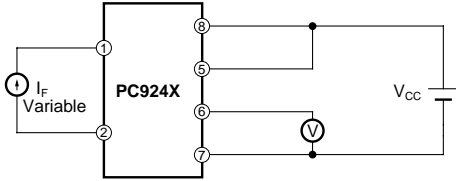


Fig.8

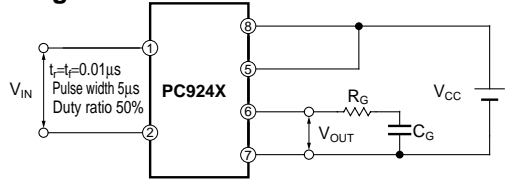


Fig.9

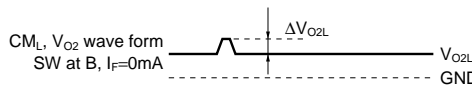
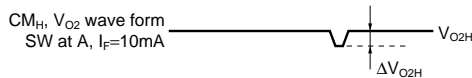
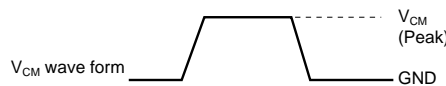
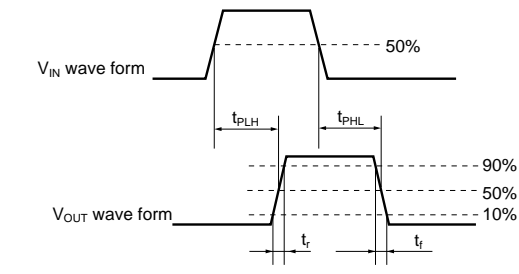
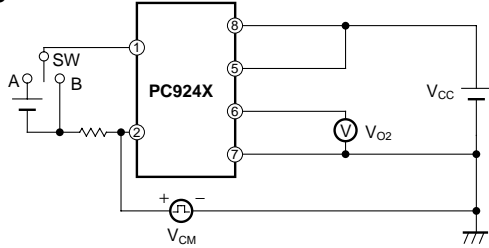


Fig.10 Forward Current vs. Ambient Temperature

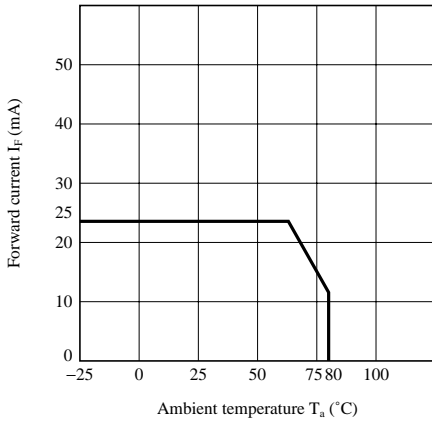


Fig.11 Power Dissipation vs. Ambient Temperature

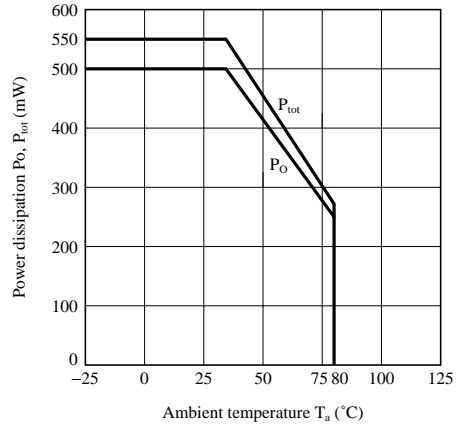


Fig.12 Forward Current vs. Forward Voltage

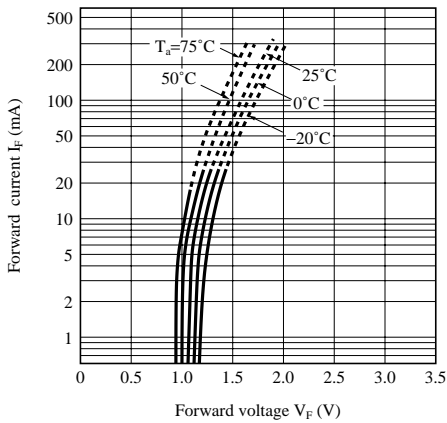


Fig.13 Relative Threshold Input Current vs. Supply Voltage

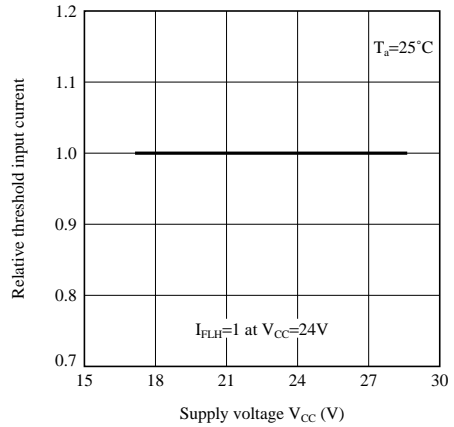


Fig.14 Relative Threshold Input Current vs. Ambient Temperature

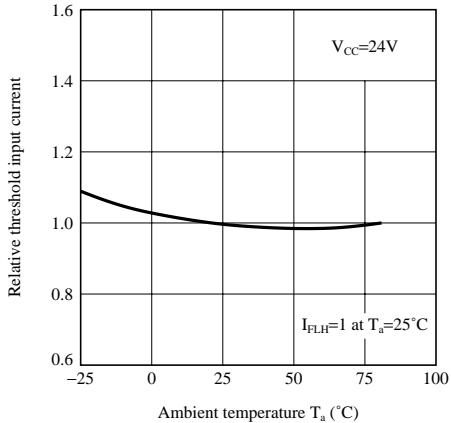


Fig.15 O₁ Low Level Output Voltage vs. O₁ Output Current

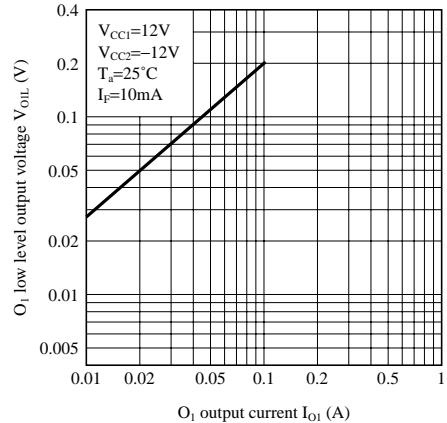


Fig.16 O₁ Low Level Output Voltage vs. Ambient Temperature

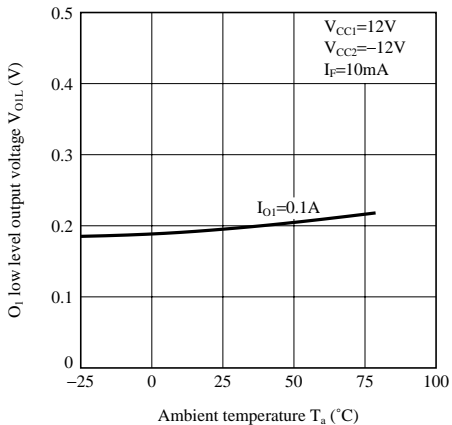


Fig.17 O₂ High Level Output Voltage vs. Supply Voltage

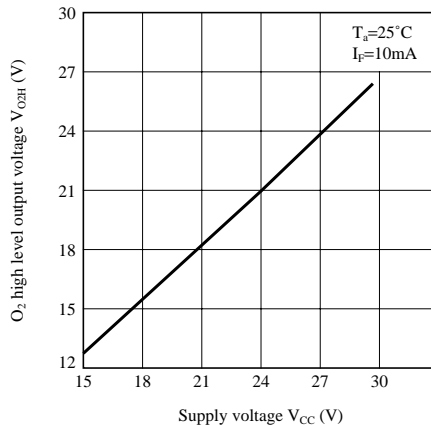


Fig.18 O₂ High Level Output Voltage vs. Ambient Temperature

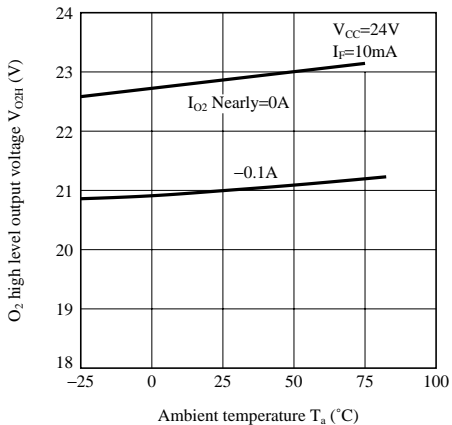


Fig.19 O₂ Low Level Output Voltage vs. O₂ Output Current

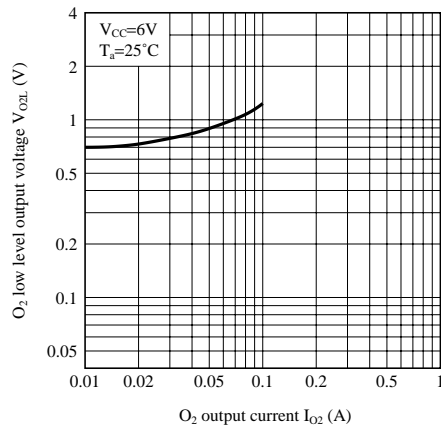


Fig.20 O₂ Low Level Output Voltage vs. Ambient Temperature

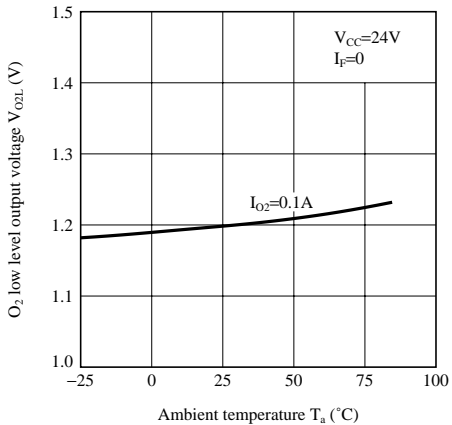


Fig.21 High Level Supply Current vs. Supply Voltage

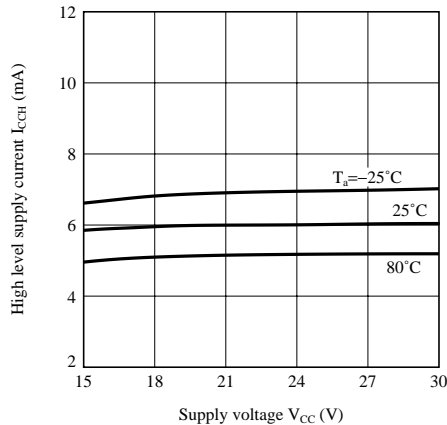


Fig.22 Low Level Supply Current vs. Supply Voltage

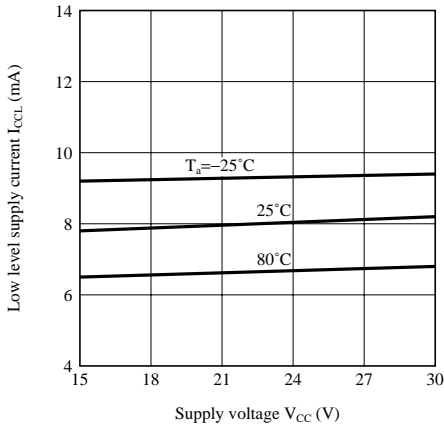


Fig.23 Propagation Delay Time vs. Forward Current

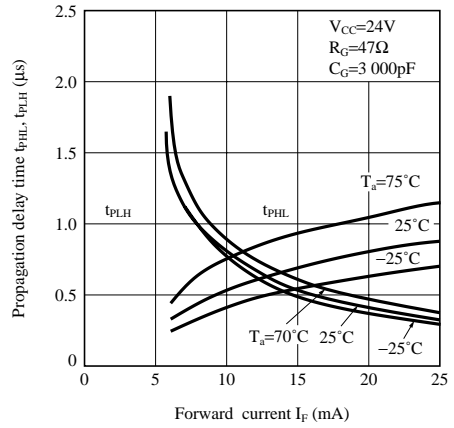
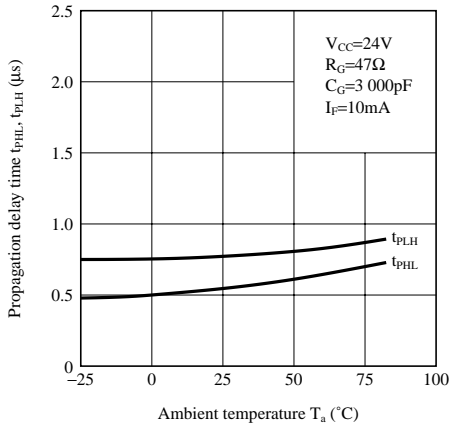
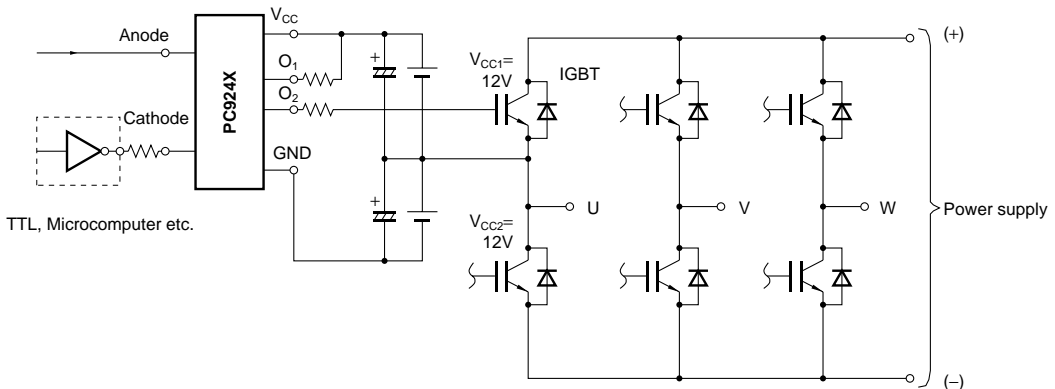


Fig.24 Propagation Delay Time vs. Ambient Temperature



■ Application Circuit (IGBT Drive for Inverter)



NOTICE

- The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.
- Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.
- Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:
 - (i) The devices in this publication are designed for use in general electronic equipment designs such as:
 - Personal computers
 - Office automation equipment
 - Telecommunication equipment [terminal]
 - Test and measurement equipment
 - Industrial control
 - Audio visual equipment
 - Consumer electronics
 - (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:
 - Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
 - Traffic signals
 - Gas leakage sensor breakers
 - Alarm equipment
 - Various safety devices, etc.
 - (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
 - Space applications
 - Telecommunication equipment [trunk lines]
 - Nuclear power control equipment
 - Medical and other life support equipment (e.g., scuba).
- If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Law of Japan, it is necessary to obtain approval to export such SHARP devices.
- This publication is the proprietary product of SHARP and is copyrighted, with all rights reserved. Under the copyright laws, no part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, for any purpose, in whole or in part, without the express written permission of SHARP. Express written permission is also required before any use of this publication may be made by a third party.
- Contact and consult with a SHARP representative if there are any questions about the contents of this publication.